

Association between maternal adverse childhood experiences and mental health problems in offspring: an intergenerational study

Doi S, Fujiwara T, Isumi A.

Development and psychopathology

2020; ePub(ePub):ePub

ARTICLE IDENTIFIERS

DOI: 10.1017/S0954579420000334

PMID: unavailable

PMCID: not available

JOURNAL IDENTIFIERS

LCCN: 93642358

pISSN: 0954-5794

eISSN: 1469-2198

OCLC ID: 19716359

CONS ID: sn 90031206

US National Library of Medicine ID: 8910645

This article was identified from a query of the SafetyLit database.